

N-Channel 100 V (D-S) MOSFET



Marking Code: AVXX

PRODUCT SUMMARY	
V_{DS} (V)	100
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10$ V	0.212
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5$ V	0.270
Q_g typ. (nC)	1.86
I_D (A) ^a	2.38
Configuration	Single

FEATURES

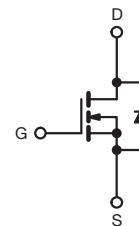
- TrenchFET® Gen IV power MOSFET
- 100 % R_g and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



RoHS
COMPLIANT
HALOGEN
FREE

APPLICATIONS

- Load switches
- DC/DC converters
- Power management
- LED backlighting



N-Channel MOSFET

ORDERING INFORMATION

Package	SOT-363
Lead (Pb)-free and halogen-free	Si1480BDH-T1-GE3

ABSOLUTE MAXIMUM RATINGS ($T_A = 25$ °C, unless otherwise noted)

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-source voltage	V_{DS}	100	V
Gate-source voltage	V_{GS}	± 20	
Continuous drain current ($T_J = 150$ °C) ^a	I_D	2.38 ^a	A
		1.9	
		1.8 ^{b, c}	
		1.4 ^{b, c}	
Pulsed drain current ($t = 300$ μ s)	I_{DM}	7	
Avalanche current	I_{AS}	3	
Repetitive avalanche energy	E_{AS}	0.45	
Continuous source-drain diode current	I_S	2.3	A
		1.3 ^{b, c}	
Maximum power dissipation ^a	P_D	2.6	W
		1.7	
		1.5 ^{b, c}	
		0.97 ^{b, c}	
Operating junction and storage temperature range	T_J, T_{stg}	-55 to +150	°C

THERMAL RESISTANCE RATINGS

PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT
Maximum junction-to-ambient ^{b, d}	R_{thJA}	62	82	°C/W
Maximum junction-to-foot (drain)	R_{thJF}	37	47	

Notes

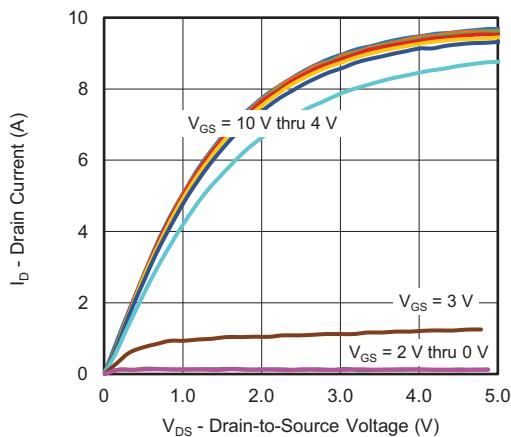
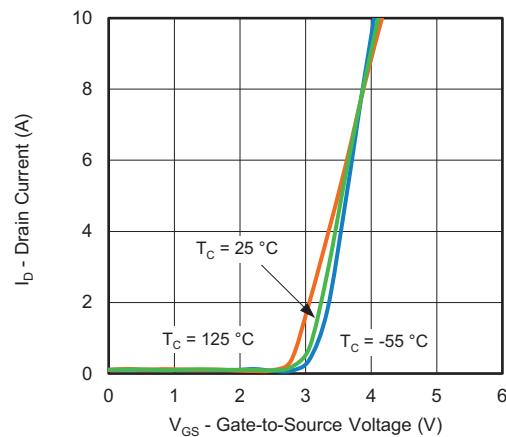
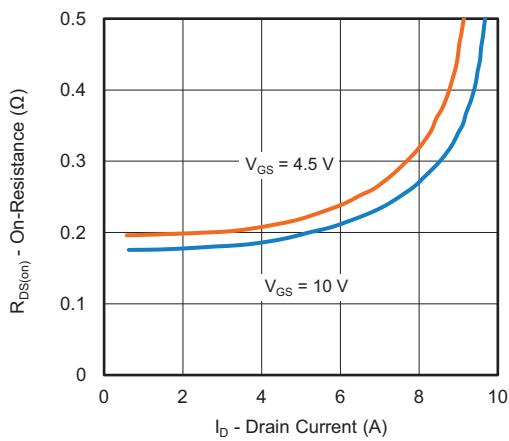
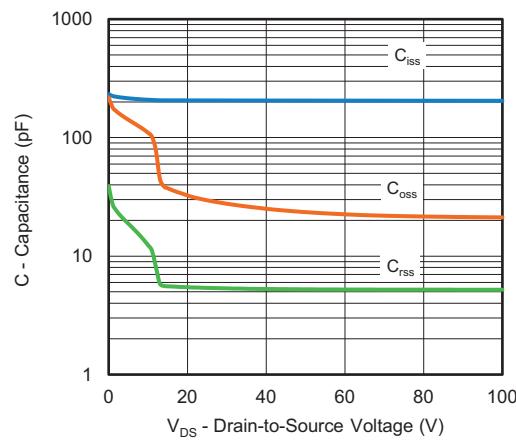
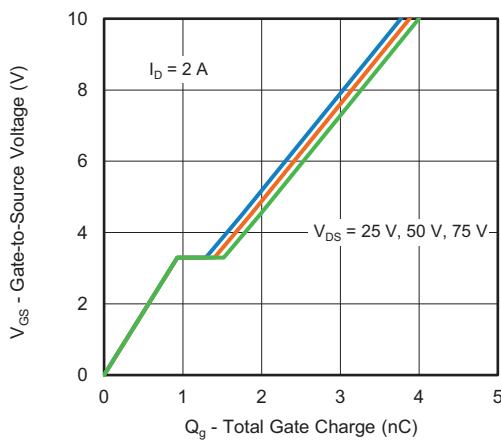
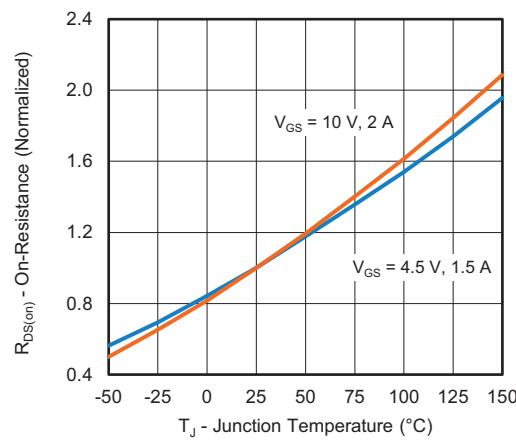
- a. Package limited
- b. Surface mounted on 1" x 1" FR4 board
- c. $t = 5$ s
- d. Maximum under steady state conditions is 130 °C/W

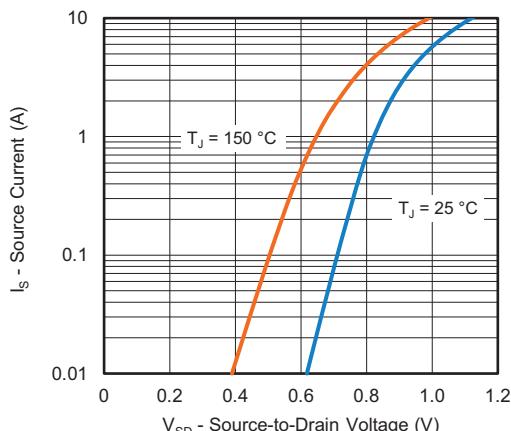
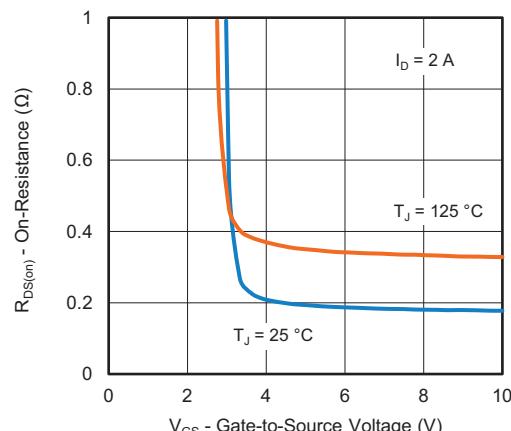
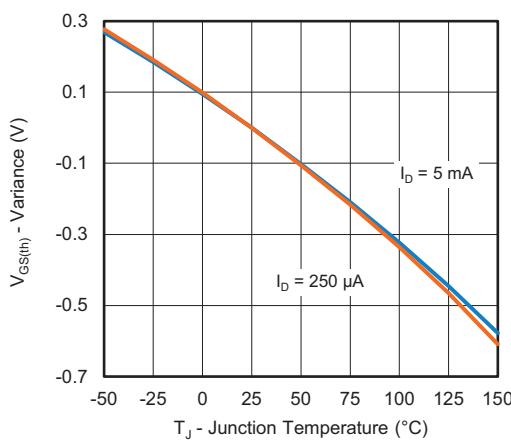
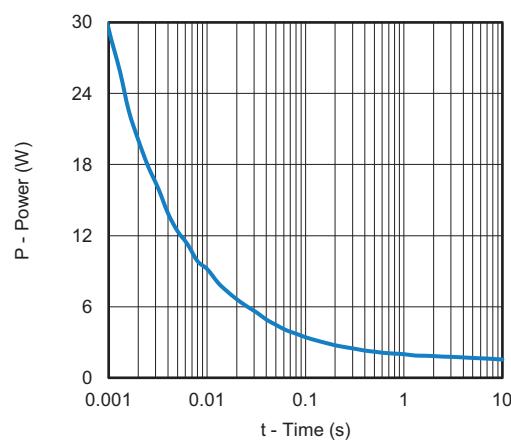
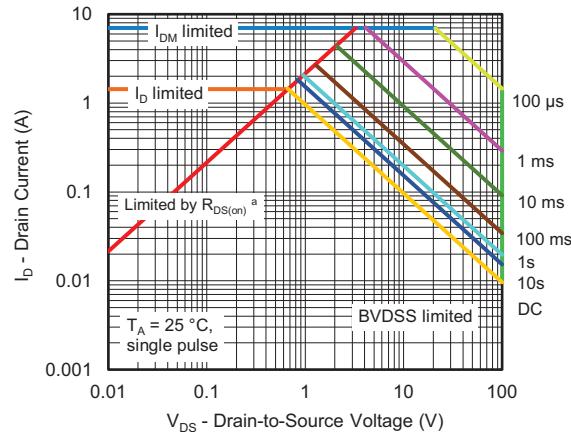
SPECIFICATIONS ($T_J = 25^\circ\text{C}$, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0\text{ V}$, $I_D = 250\text{ }\mu\text{A}$	100	-	-	V	
V_{DS} temperature coefficient	$\Delta V_{DS}/T_J$	$I_D = 250\text{ }\mu\text{A}$	-	87	-	mV/°C	
$V_{GS(\text{th})}$ temperature coefficient	$\Delta V_{GS(\text{th})}/T_J$		-	-4.3	-		
Gate-source threshold voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}$, $I_D = 250\text{ }\mu\text{A}$	1.6	-	3	V	
Gate-source leakage	I_{GSS}	$V_{DS} = 0\text{ V}$, $V_{GS} = \pm 20\text{ V}$	-	-	± 100	nA	
Zero gate voltage drain current	I_{DSS}	$V_{DS} = 100\text{ V}$, $V_{GS} = 0\text{ V}$	-	-	1	μA	
		$V_{DS} = 100\text{ V}$, $V_{GS} = 0\text{ V}$, $T_J = 55^\circ\text{C}$	-	-	10		
Drain-source on-state resistance ^a	$R_{DS(\text{on})}$	$V_{GS} = 10\text{ V}$, $I_D = 2\text{ A}$	-	0.176	0.212	Ω	
		$V_{GS} = 4.5\text{ V}$, $I_D = 1.5\text{ A}$	-	0.196	0.270		
Forward transconductance	g_{fs}	$V_{DS} = 10\text{ V}$, $I_D = 2\text{ A}$	-	9	-	S	
Dynamic ^b							
Input capacitance	C_{iss}	$V_{DS} = 50\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$	-	206	-	pF	
Output capacitance	C_{oss}		-	24	-		
Reverse transfer capacitance	C_{rss}		-	5	-		
Total gate charge	Q_g	$V_{DS} = 50\text{ V}$, $V_{GS} = 10\text{ V}$, $I_D = 2\text{ A}$	-	3.9	6.0	nC	
		$V_{DS} = 50\text{ V}$, $V_{GS} = 4.5\text{ V}$, $I_D = 2\text{ A}$	-	1.86	3.0		
Gate-source charge	Q_{gs}		-	0.93	-		
Gate-drain charge	Q_{gd}		-	0.5	-		
Gate resistance	R_g	$f = 1\text{ MHz}$		0.5	2.0	3.5	Ω
Turn-on delay time	$t_{d(\text{on})}$	$V_{DD} = 50\text{ V}$, $R_L = 25\text{ }\Omega$ $I_D \geq 2\text{ A}$, $V_{GEN} = 4.5\text{ V}$, $R_g = 1\text{ }\Omega$	-	11	22	ns	
Rise time	t_r		-	25	50		
Turn-off delay time	$t_{d(\text{off})}$		-	10	20		
Fall time	t_f		-	12	24		
Turn-on delay time	$t_{d(\text{on})}$	$V_{DD} = 50\text{ V}$, $R_L = 25\text{ }\Omega$ $I_D \geq 2\text{ A}$, $V_{GEN} = 10\text{ V}$, $R_g = 1\text{ }\Omega$	-	6	12	ns	
Rise time	t_r		-	4	8		
Turn-off delay time	$t_{d(\text{off})}$		-	10	20		
Fall time	t_f		-	3	6		
Drain-Source Body Diode Characteristics							
Continuous source-drain diode current	I_S	$T_C = 25^\circ\text{C}$	-	-	2.3	A	
Pulse diode forward current ^a	I_{SM}		-	-	7		
Body diode voltage	V_{SD}	$I_S = 2\text{ A}$, $V_{GS} = 0\text{ V}$	-	0.85	1.2	V	
Body diode reverse recovery charge	Q_{rr}	$I_F = 2\text{ A}$, $dI/dt = 100\text{ A}/\mu\text{s}$, $T_J = 25^\circ\text{C}$	-	22	44	nC	
Body diode reverse recovery time	t_{rr}		-	20	40	ns	
Reverse recovery fall time	t_a		-	18	-		
Reverse recovery rise time	t_b		-	3	-		

Notes

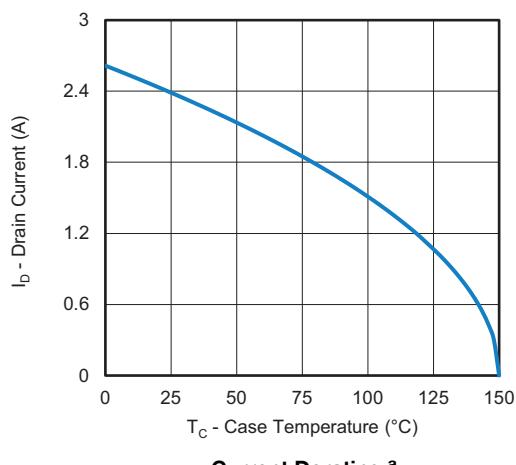
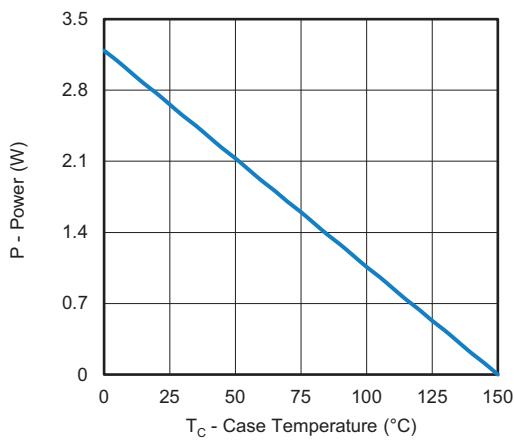
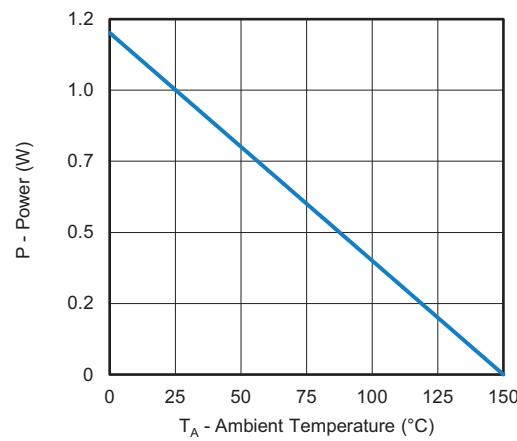
a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\text{ \%}$
b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

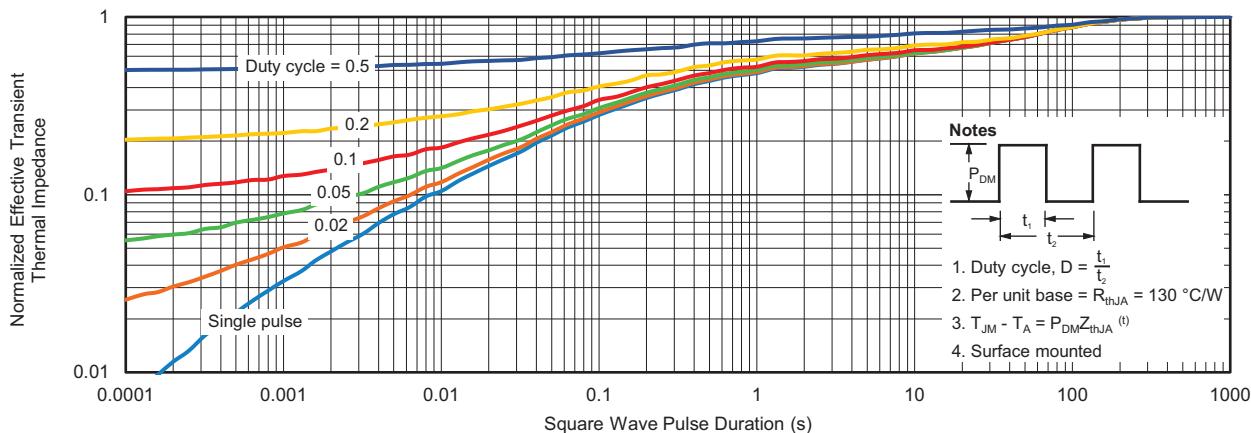
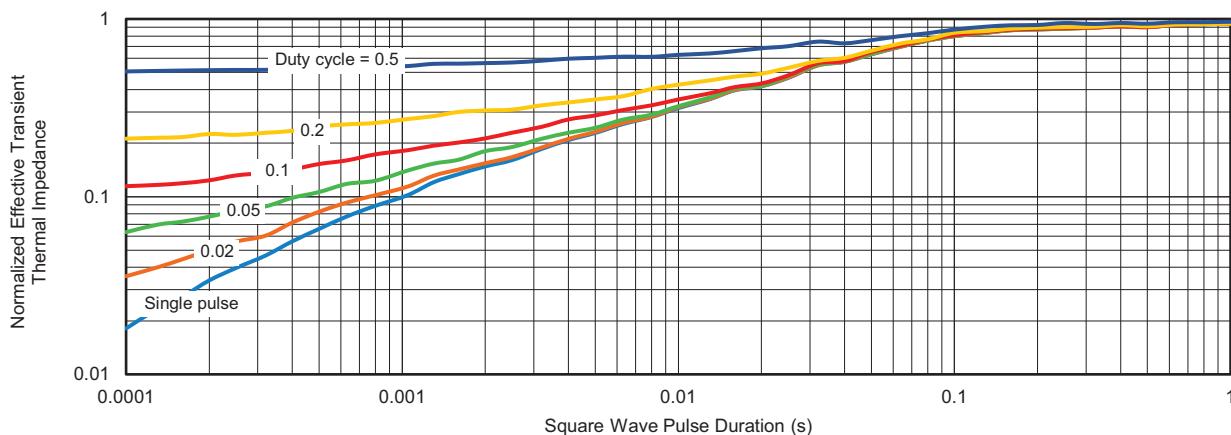
TYPICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$, unless otherwise noted)

Output Characteristics

Transfer Characteristics Curves vs. Temperature

On-Resistance vs. Drain Current

Capacitance

Gate Charge

On-Resistance vs. Junction Temperature

TYPICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$, unless otherwise noted)

Source-Drain Diode Forward Voltage

 $R_{DS(on)}$ vs. V_{GS} vs. Temperature

Threshold Voltage

Single Pulse Power

Safe Operating Area, Junction-to-Ambient
Note

a. $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified

TYPICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$, unless otherwise noted)

Current Derating ^a

Power, Junction-to-Case

Power, Junction-to-Ambient
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit

TYPICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$, unless otherwise noted)

Normalized Thermal Transient Impedance, Junction-to-Ambient

Normalized Thermal Transient Impedance, Junction-to-Foot

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